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Subtractive 3D Printing of Optically Active Diamond Structures

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Controlled fabrication of semiconductor nanostructures is an essential step in engineering of high performance photonic and optoelectronic devices. Diamond in particular has recently attracted considerable attention as a promising platform for quantum technologies, photonics and high resolution sensing applications. Here we demonstrate the fabrication of optically active, functional diamond structures using gas-mediated electron beam induced etching (EBIE). The technique achieves dry chemical etching at room temperature through the dissociation of surface-adsorbed H₂O molecules by energetic electrons in a water vapor environment. Parallel processing is possible by electron flood exposure and the use of an etch mask, while high resolution, mask-free, iterative editing is demonstrated by direct write etching of inclined facets of diamond microparticles. The realized structures demonstrate the potential of EBIE for the fabrication of optically active structures in diamond.

Diamond, long considered unconquerable due to its extraordinary strength and chemical resistance, has found applications across numerous areas of science due to its unique combination of optical, electronic, chemical and thermal properties¹. Most notably, the nitrogen vacancy luminescence center (NV) has been employed as a spin qubit, enabling the use of diamond as a platform for next generation sensing, nanophotonic and quantum devices^{2–8}. These tantalizing applications are, however, overshadowed by challenges in fabrication arising from its extraordinary hardness and chemical resistance.

At present, diamond fabrication requires cumbersome masking techniques, and ion bombardment or high power laser ablation, which often causes damage and material redeposition artifacts^{9–13}. Fabrication and editing of optoelectronic grade nanostructures is therefore extremely limited relative to conventional semiconductors such as silicon and gallium arsenide. Furthermore, direct-write, deterministic patterning of optical structures in diamond has not been demonstrated in the absence of severe surface damage caused by ion implantation and redeposition of non-volatile, sputtered or ablated material.

Here we demonstrate the fabrication of functional, optically active diamond structures using gas-mediated electron beam induced etching (EBIE)^{14–18} (Figure 1). EBIE achieves dry chemical etching at room temperature in a water vapor environment through the electron-induced dissociation of surface-adsorbed H₂O molecules, generating reactive fragments that give rise to volatilization of carbon. The reaction steps are shown in Figure 1b–c. The process utilizes low energy electrons which do not cause damage through knock-on displacement of carbon, sputtering and staining that are characteristic of focused ion beam milling, and cause quenching of diamond luminescence^{14,19}. Parallel processing is possible by electron flood exposure and the use of an etch mask. Mask-free EBIE is used to realize direct-write subtractive 3D printing of diamond nanostructures on inclined planes of diamond microparticles. The processes are demonstrated using a variable pressure scanning electron microscope (SEM) making diamond nanofabrication accessible to most nanotechnology laboratories in the world.

To demonstrate the applicability of EBIE to device fabrication, we start by fabricating a pillar from a single crystal diamond using an etch mask. Pillars are used as antennas that enhance light extraction from embedded emitters, particularly of high refractive index semiconductors. The EBIE process is shown schematically in Figure 2a–c. The mask must either absorb the incident electrons or prevent H₂O from adsorbing to the diamond substrate. Here we use a silica mask to prevent low-energy (2 keV) electrons from penetrating into underlying regions of diamond. The resulting pillars (Figure 2d) have high aspect ratios and straight side-walls, making them ideal for photonic applications. The minimum pillar diameter is ultimately limited by the diameter of the interaction volume of a delta function electron beam, which scales super-linearly²⁰ with electron energy. In diamond, it is equal to ~19 nm at 2 keV, and ~9 nm at 1 keV, as shown in Figure 2e²¹. Nanostructures can

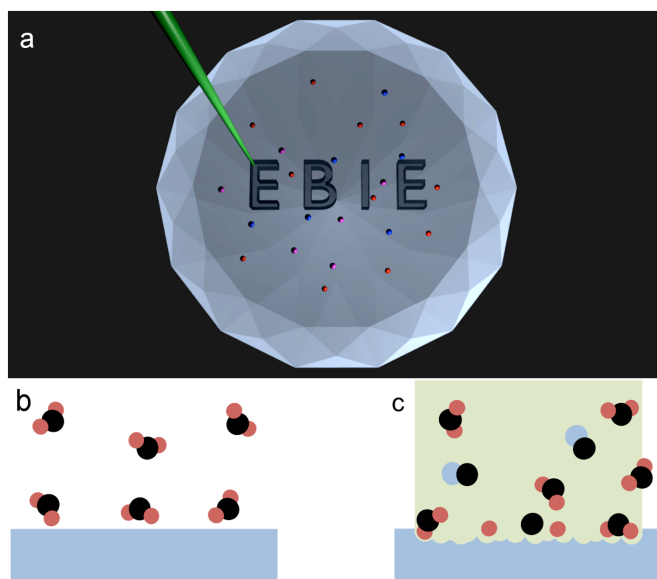


Figure 1 | Schematic illustrations of H₂O mediated electron beam induced etching. (a) Direct-write subtractive printing of diamond. (b–c) Volatilization of diamond by electron exposure in a gaseous H₂O environment.

therefore be fabricated with high resolution using the correct combination of mask diameter and electron energy. On the other hand, micron sized depths can be achieved, enabling high aspect ratio geometries.

Optical properties of the pillars are shown by the fluorescence and Raman scattering data in Figure 3. Photoluminescence (PL) spectra were recorded using a confocal microscope with a 532 nm excitation laser. The PL intensity of the pillar (Figure 3a) shows a two-fold increase over the neighboring, unprocessed region of diamond (under identical PL collection conditions). Raman spectroscopy (Figure 3b) shows no evidence of graphitic inclusions in the irradiated area with the first-order diamond peak positioned at 1332 cm^{-1} and FWHM of $\sim 3.6\text{ cm}^{-1}$, consistent with the Raman signature of pristine, single crystal diamond^{22,23}.

Next, we demonstrate the capability of EBIE for mask-free editing of inclined diamond surfaces. Editing of multiple inclined facets is nearly impossible by mask-based processing techniques, including electron- and photo-lithography. To demonstrate the three dimensional capability of writing on inclined surfaces, we patterned the letters ‘UTS’ and ‘NANO’ into individual microparticles (Figure 4) simply by tracing out the letters using an electron beam as shown schematically in Figure 1d. Etching was carried out using a 20 keV electron beam, while charging was stabilized using a low vacuum (13 Pa) environment of H₂O. The letters are clearly visible in SEM images (Figure 4a), while atomic force microscope (AFM) maps of the ‘UTS’ logo show line widths and depths of $\sim 100\text{ nm}$ (Figure 4b). The letters ‘NANO’ were written intentionally across three diamond (111) facets, showing the ability of EBIE to edit three dimensional, inclined nanostructures. Figure 4c shows an individual diamond microparticle with visible (111) facets and Figure 4e shows the word ‘NANO’ imprinted in the crystal, with the letters ‘NA’, ‘N’ and ‘O’, occupying all three (111) planes, respectively. PL measurements recorded from the diamond microparticles exhibit strong fluorescence, confirming that the etch process does not destroy optical properties and material functionality (See Supplementary Information). The mask-less patterning approach is particularly attractive for generation of high resolution microfluidic channels in microdiamond crystals, in close proximity to optical emitters^{24,25}.

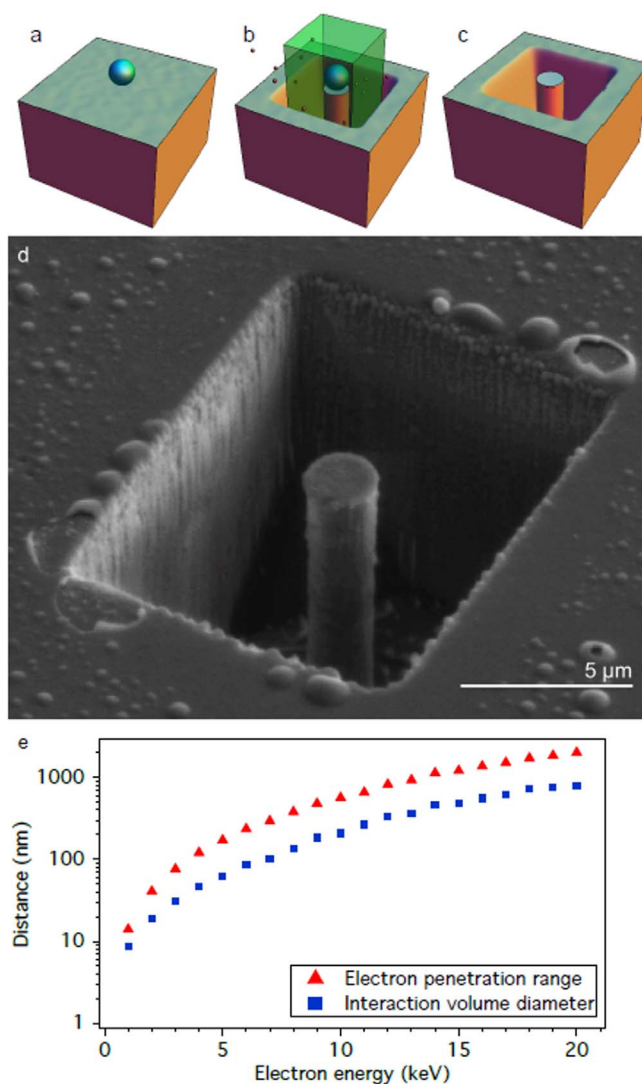


Figure 2 | Diamond pillar fabricated by mask-based EBIE. (a–c) Schematic illustration of pillar fabrication by H₂O mediated EBIE. (a) Silica bead on a diamond surface. (b) Diamond volatilization achieved by scanning a 2 keV electron beam over a rectangle repeatedly in a H₂O environment. The silica bead acts as an etch mask that prevents the electrons from reaching the diamond surface. (c) Final pillar geometry after the silica bead was removed from the substrate. (d) Electron image of a pillar fabricated in single crystal diamond by H₂O-mediated EBIE using the process shown in a–c. (e) Depth and diameter of the electron interaction volume that contains 90% of the energy deposited into diamond, plotted as a function of electron energy. The values were calculated using a Monte Carlo model of electron-solid interactions.

The potential of EBIE exceeds that of traditional etching techniques for wide bandgap semiconductors. For instance, a combination of EBIE with cathodoluminescence analysis techniques may enable probing of the spectroscopic properties of nanostructures while the etch parameters are modified during fabrication. Alternatively, substrate tilting can enable fabrication of undercut structures that are currently not available in diamond. Finally, the EBIE method will be pivotal for realizing hybrid devices when direct sculpting of a nanostructure is required to achieve close proximity with an external cavity or metallic nanostructure²⁶.

We have demonstrated a promising approach to pattern and sculpt optically active diamond structures using two variants of H₂O-mediated electron induced chemical etching: a mask-based

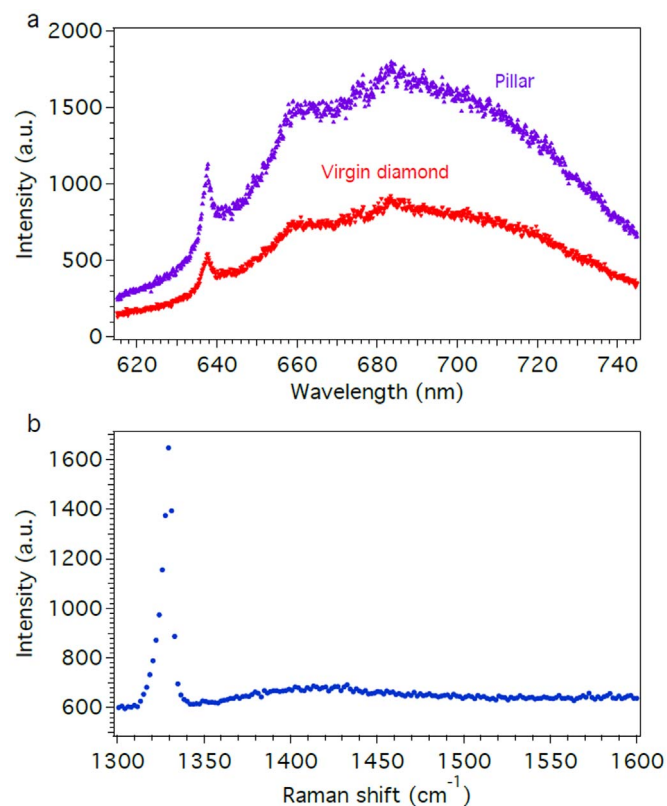


Figure 3 | Optical quality of a diamond pillar fabricated by EBIE. (a) PL spectra of the pillar and an adjacent, unprocessed region of diamond. (b) Raman spectrum of the pillar showing the absence of defects generated by EBIE.

lithographic approach, and an extremely versatile, direct-write editing process. For the first time, direct 3D writing is realized on various facets of a single microparticle. PL and Raman analysis were used to show that the unique optical properties of diamond are maintained and no graphitization occurs. By leveraging the advanced functionalities provided by a conventional SEM in conjunction with EBIE a modification to existing devices and direct nanofabrication for rapid prototyping is enabled. EBIE is the first step towards rendering 3D single crystal diamond geometries for high performance photonic, sensing and quantum devices.

Methods

EBIE of diamond pillar. EBIE was performed using a FEI Nova NanoSEM variable pressure²⁷ scanning electron microscope (SEM) equipped with a magnetic immersion lens gaseous secondary electron detector²⁸. The SEM chamber was pumped to 3×10^{-4} Pa prior to performing EBIE at room temperature under 13 Pa of H₂O (Milli-Q) precursor vapor. Pillars were fabricated using dispersed 2 μ m silica beads that served as a hard mask on a 100 oriented single crystal diamond (Element Six). Silica beads were transferred from a suspension in isopropyl alcohol, which was flash dried to remove the solvent. Single beads were located in the SEM before irradiation. H₂O mediated EBIE was performed by irradiating a 10 μ m \times 8 μ m rectangle with a 2 keV, 29.9 nA electron beam for 12 hours, using a dwell time of 1.34 ms per pixel. Electron penetration and energy deposition profiles were calculated using standard Monte Carlo models of electron-solid interactions^{21,29}.

Optical measurements. PL measurements were performed at room temperature using a custom built confocal microscope with a 532 nm excitation laser. Raman measurements were performed using a Renishaw inVia Raman microscope with a 633 nm excitation laser.

EBIE of diamond micro particles. Diamond micro-particles were grown using a CVD method (\sim 950 W, 1% methane, 8×10^3 Pa). The particles were transferred to a platinum surface prior to EBIE. The 'UTS' symbol was etched into a single particle using a 20 keV, 9.9 nA electron beam controlled using a custom pattern generator connected to the SEM scan coils. The dwell time per pixel was 256 ms and the total process time \sim 15 mins. The symbol 'NANO' was etched using the same conditions, but etch letter was etched individually into the diamond. The 'UTS' symbol was measured ex situ using the tapping mode of a DI Dimension 3100 atomic force microscope (AFM), and analyzed using the software package Gwyddion³⁰.

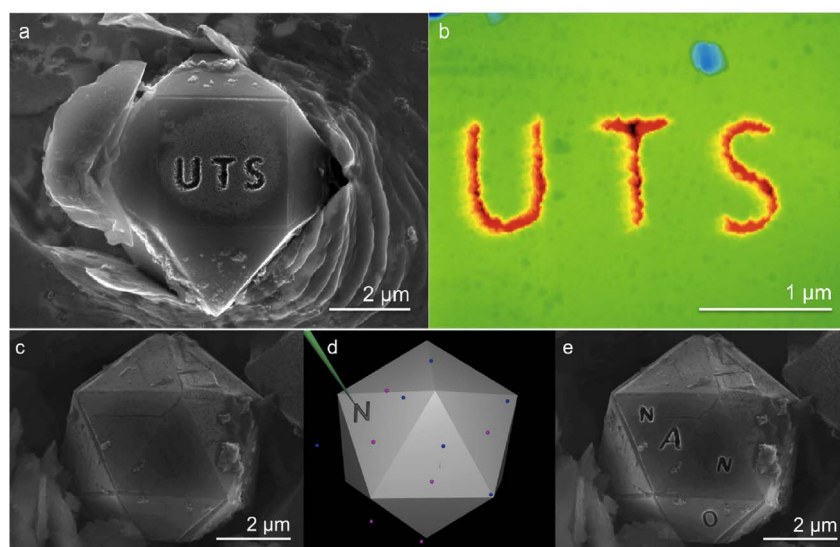


Figure 4 | Beam-directed editing of Si-doped diamond micro-particles. (a) SEM image of the symbol 'UTS' patterned by H₂O mediated EBIE on the 110 plane of a single diamond micro-particle embedded in platinum. (b) AFM image of the symbol 'UTS' shown in a (depth of each letter \sim 100 nm). (c) SEM image of a diamond micro-particle. (d) Schematic illustration of the process used to pattern the micro-particle shown in c. Each letter of 'NANO' was patterned individually using H₂O mediated EBIE on three different 111 faces of diamond. (e) SEM image of the microparticle shown in c after the letters 'NANO' were patterned by EBIE.



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Author contributions

A.M. performed the experiments, and wrote the paper with contributions from all co-authors. A.M., M.T. and I.A. discussed the data and analyzed the results.

Additional information

Supplementary information accompanies this paper at <http://www.nature.com/scientificreports>

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